

Half-Bridge (Full SiC)

SK250MB120CR03TE2

Features\*

- Optimized design for superior thermal performance
- Extremely low inductance design
- Press-Fit contact technology
- 1200V Planar Gen3 SiC MOSFET
- Simple to drive with +15V gate voltage
- Optimized switching stability thanks to module integrated gate resistors
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

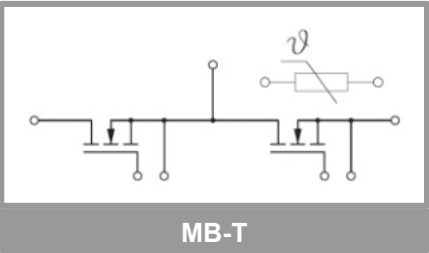
- Switched Mode Power Supplies
- Energy Storage Systems
- Electric Vehicle charging
- UPS
- Solar

Remarks

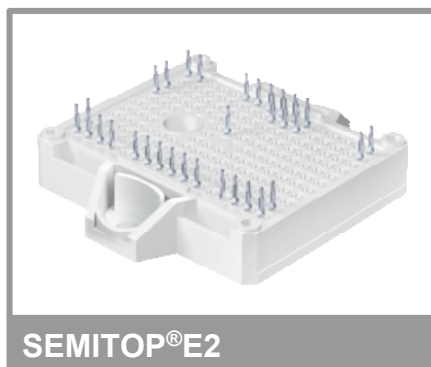
- Recommended  $T_{jop} = -40^{\circ}\text{C} \dots +150^{\circ}\text{C}$
- Recommended turn-off / turn-on gate voltage  $V_{GS} = -4 \dots 0/+15\text{V}$

Absolute Maximum Ratings			
Symbol	Conditions	Values	Unit
MOSFET			
$V_{DSS}$	$T_j = 25^{\circ}\text{C}$	1200	V
$I_D$	HPTP / HP-PCM $T_j = 175^{\circ}\text{C}$	$T_s = 25^{\circ}\text{C}$	267
		$T_s = 70^{\circ}\text{C}$	223
$I_{DM}$	Pulse width $t_p$ limited by $T_{vjmax}$	720	A
$V_{GS}$	Transient Gate - Source voltage ( $t < 100\text{ns}$ )	-8 ... 19	V
$T_j$		-40 ... 175	$^{\circ}\text{C}$
Integrated body diode			
$I_{FM}$	Pulse width $t_p$ limited by $T_{vjmax}$	720	A
$I_{FSM}$	$t_p = 10\text{ ms}$ , $\sin 180^{\circ}$ , $T_j = 150^{\circ}\text{C}$	1076	A

Absolute Maximum Ratings			
Symbol	Conditions	Values	Unit
Module			
$I_{t(RMS)}$	$\Delta T_{terminal}$ at PCB joint = 30 K, per pin	30	A
$T_{stg}$	module without TIM	-40 ... 125	$^{\circ}\text{C}$
$V_{isol}$	AC, sinusoidal, $t = 1\text{ min}$	2500	V



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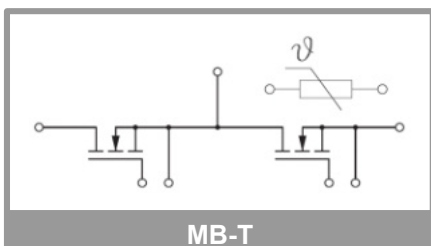
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Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
<b>MOSFET</b>					
$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}, I_D = 0.6\text{ mA}, T_j = 25^{\circ}\text{C}$	1200			V
$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 69\text{ mA}, T_j = 25^{\circ}\text{C}$	1.8	2.5	3.6	V
$I_{DSS}$	$V_{GS} = 0\text{ V}, V_{DS} = 1200\text{ V}, T_j = 25^{\circ}\text{C}$			0.6	mA
$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = 15\text{ V}, T_j = 25^{\circ}\text{C}$			400	nA
$R_{DS(on)}$	$V_{GS} = 15\text{ V}, I_D = 248\text{ A}, \text{chiplevel}$	$T_j = 25^{\circ}\text{C}$	5.3	7.2	mΩ
		$T_j = 150^{\circ}\text{C}$	8.3		mΩ
$C_{iss}$	$V_{GS} = 0\text{ V}, f = 0.1\text{ MHz}$		20400		pF
$C_{oss}$	$V_{DS} = 1000\text{ V}, f = 0.1\text{ MHz}$		780		pF
$C_{rss}$	$T_j = 25^{\circ}\text{C}, f = 0.1\text{ MHz}$		60		pF
$Q_G$	$V_{GS} = -4 \dots 15\text{ V}, V_{DD} = 800\text{ V}, I_D = 248\text{ A}$		708		nC
$R_{Gint}$	$T_j = 25^{\circ}\text{C}$		2.3		Ω
$t_{d(on)}$	$V_{DD} = 600\text{ V}, T_j = 150^{\circ}\text{C}$		49		ns
$t_{d(off)}$	$I_D = 240\text{ A}, T_j = 150^{\circ}\text{C}$		120		ns
$t_r$	$V_{GS} = -4/+15\text{ V}, T_j = 150^{\circ}\text{C}$		17		ns
$t_f$	$R_{Gon/off} = 0.5\text{ Ω}, T_j = 150^{\circ}\text{C}$		29		ns
$E_{on}$	$di/dt_{off} = 15\text{ kA/μs}, T_j = 150^{\circ}\text{C}$		2.97		mJ
$E_{off}$	$di/dt_{on} = 22\text{ kA/μs}, dv/dt = 29\text{ kV/μs}, L_s = 5\text{ nH}, T_j = 150^{\circ}\text{C}$		2.57		mJ
$R_{th(j-s)}$	per MOSFET, HPTP / HP-PCM		0.19		K/W
<b>Integrated body diode</b>					
$V_F = V_{SD}$	$-I_D = 124\text{ A}, V_{GS} = -4\text{ V}, \text{chiplevel}$	$T_j = 25^{\circ}\text{C}$	4.6		V
		$T_j = 150^{\circ}\text{C}$	4.3		V
$V_{F0} = V_{SD0}$	chiplevel	$T_j = 25^{\circ}\text{C}$	3.8		V
		$T_j = 150^{\circ}\text{C}$	3.6		V
$r_F = r_{SD}$	chiplevel	$T_j = 25^{\circ}\text{C}$	6.4		mΩ
		$T_j = 150^{\circ}\text{C}$	5.6		mΩ
$t_{rr}$	$V_{DD} = 600\text{ V}, T_j = 150^{\circ}\text{C}$		40		μs
$Q_{rr}$	$-I_D = 240\text{ A}, T_j = 150^{\circ}\text{C}$		6.7		μC
$I_{rr}$	$V_{GS} = -4\text{ V}, T_j = 150^{\circ}\text{C}$		337		A
$E_{rr}$	$R_{Gon} = 0.5\text{ Ω}, di/dt_{off} = 23\text{ kA/μs}, T_j = 150^{\circ}\text{C}$		2.21		mJ

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
<b>Module</b>					
$L_{CE}$			6		nH
$M_s$	to heatsink	1.6		2.3	Nm
w	weight		35		g

Characteristics					
Symbol	Conditions	min.	typ.	max.	Unit
<b>Temperature Sensor</b>					
$R_{100}$	$T_r = 100^{\circ}\text{C}$		$493 \pm 5\%$		Ω
$B_{100/125}$	$R_{(T)} = R_{100} \cdot \exp[B_{100/125} \cdot (1/T - 1/T_{100})], T[K];$		$3550 (\pm 2\%)$		K

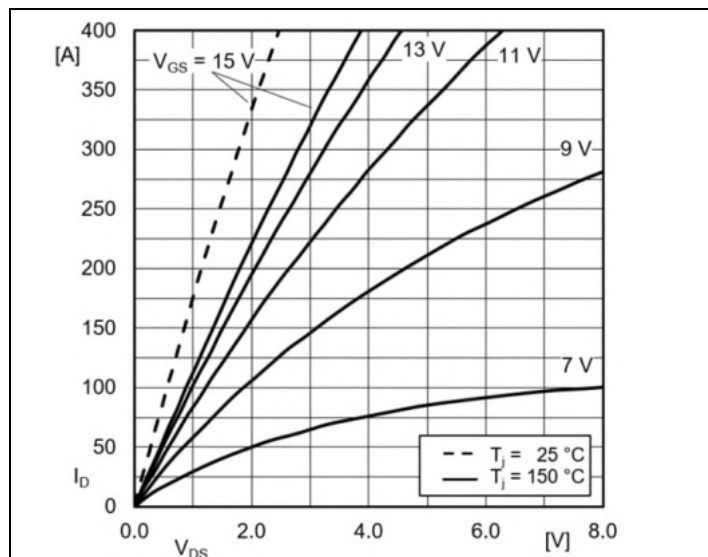


Fig. 1: Typ. MOSFET forward output characteristic, incl.  $R_{DD}'+ ss'$

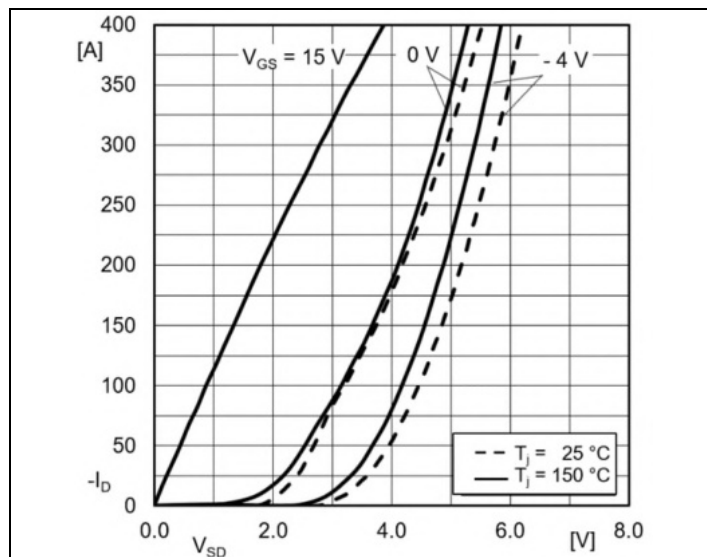


Fig. 1a: Typ. MOSFET reverse output characteristic, incl.  $R_{DD}'+ ss'$

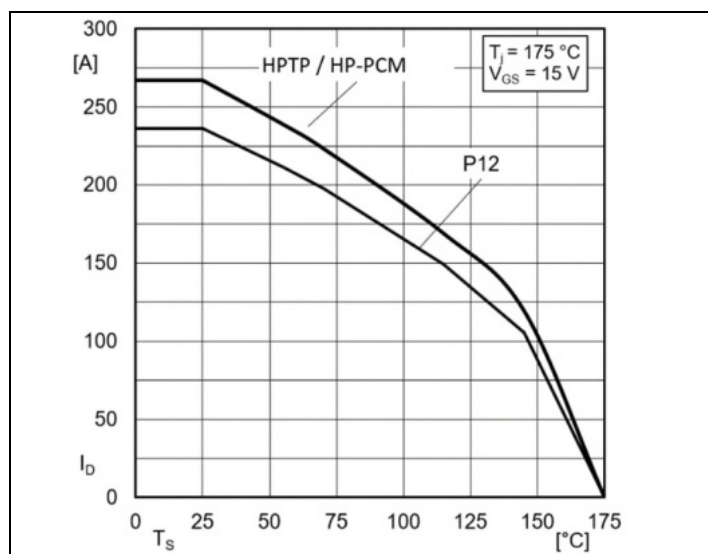


Fig. 2: MOSFET Rated current vs. temperature  $I_D = f(T_s)$

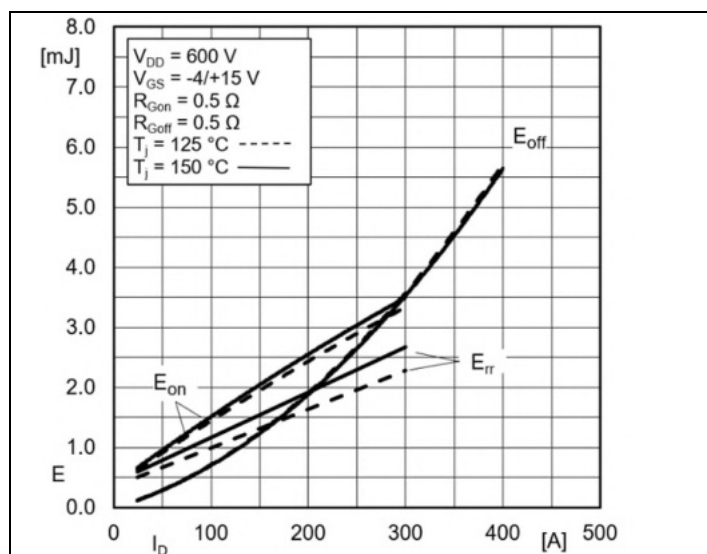


Fig. 3: Typ. MOSFET switching energy  $E = f(I_D)$  at  $R_{G1}$

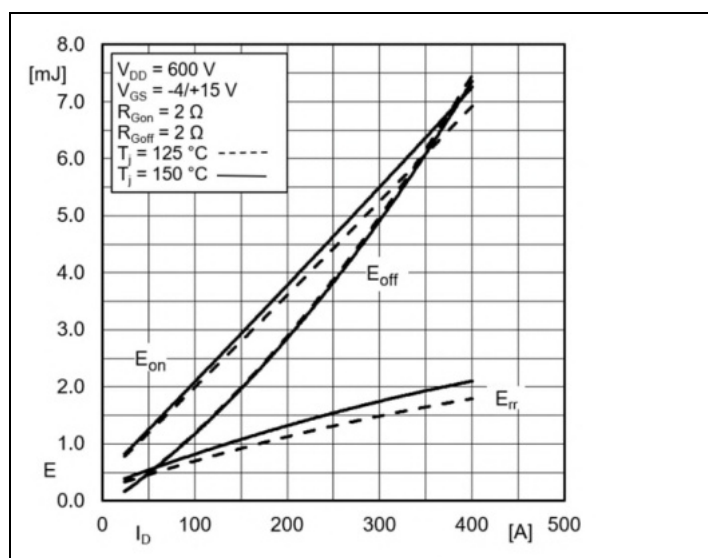


Fig. 3a: Typ. MOSFET switching energy  $E = f(I_D)$  at  $R_{G2}$

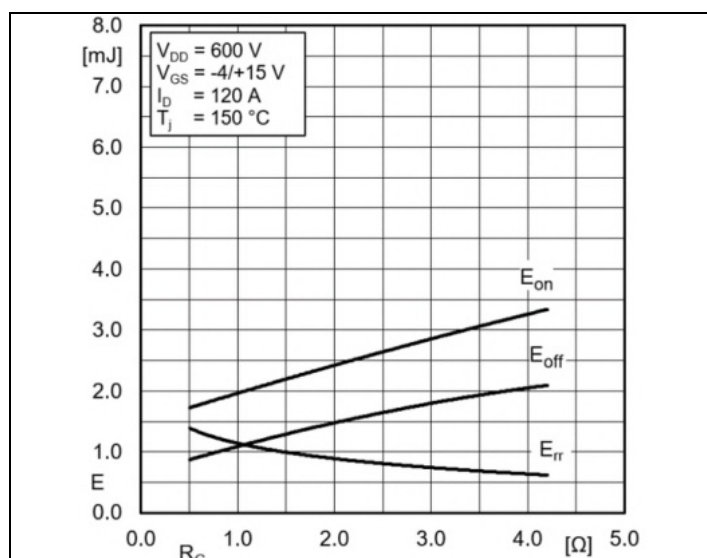


Fig. 4: Typ. MOSFET switching energy  $E = f(R_G)$  at  $I_{D1}$

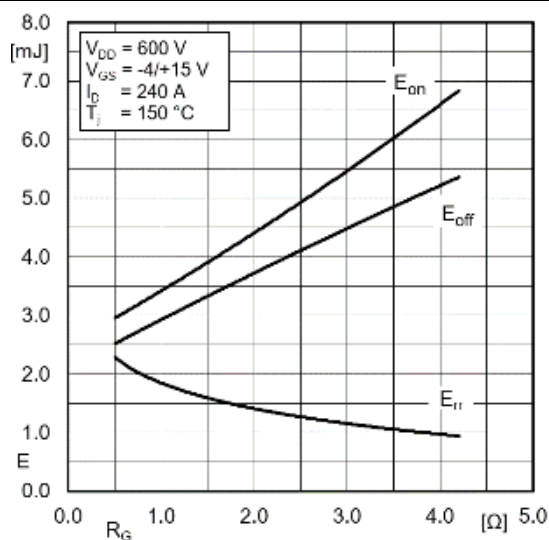


Fig. 4a: Typ. MOSFET switching energy  $E = f(R_G)$  at  $I_{D2}$

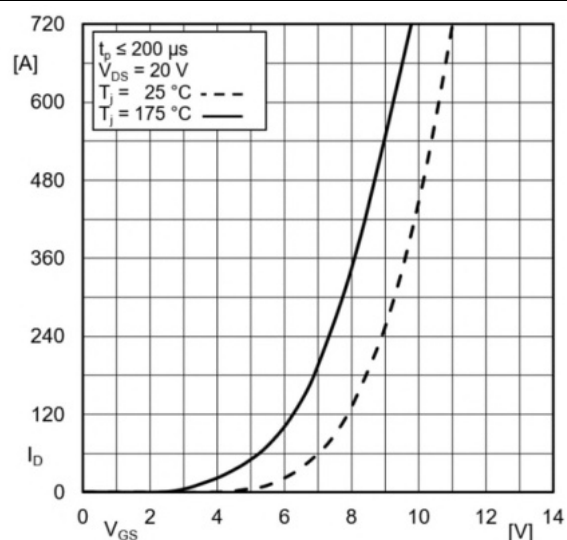


Fig. 5: Typ. MOSFET transfer characteristic

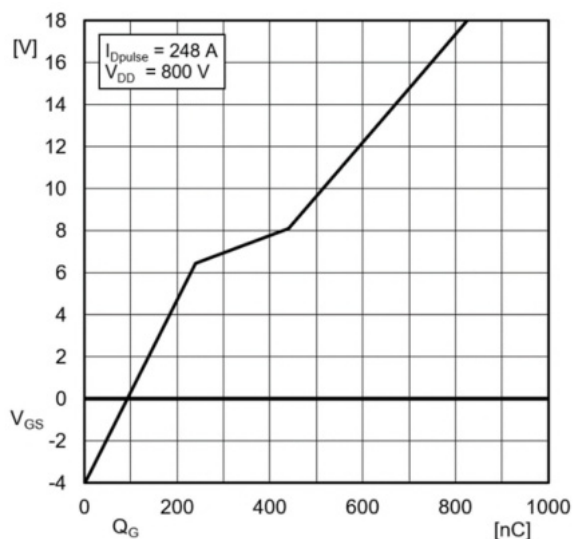


Fig. 6: Typ. MOSFET gate charge characteristic

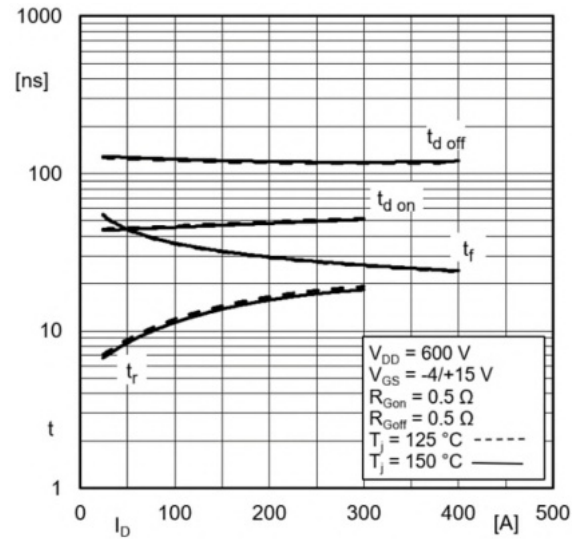


Fig. 7: Typ. MOSFET switching times  $t = f(I_D)$  at  $R_{G1}$

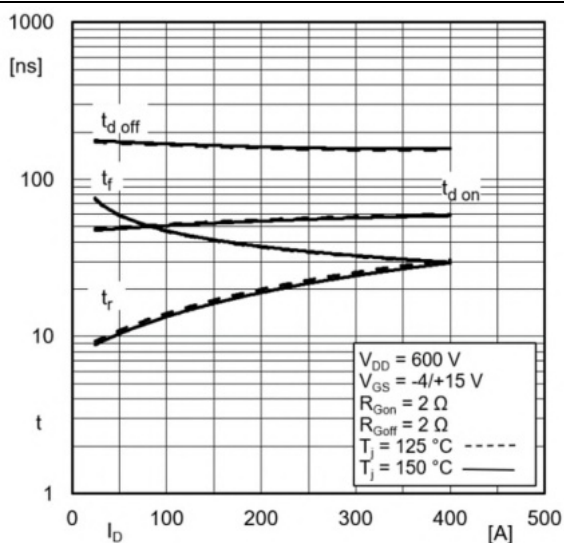


Fig. 7a: Typ. MOSFET switching times  $t = f(I_D)$  at  $R_{G2}$

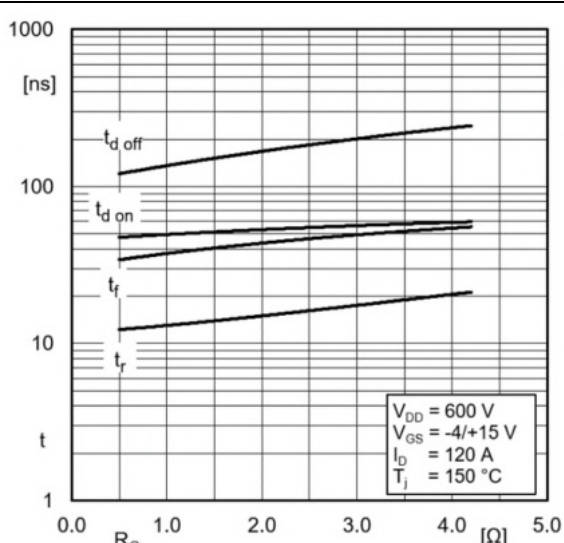
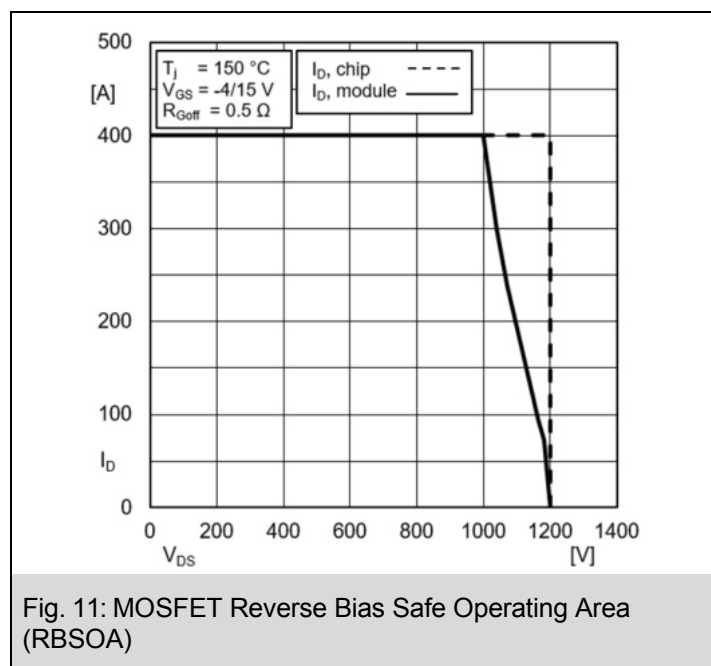
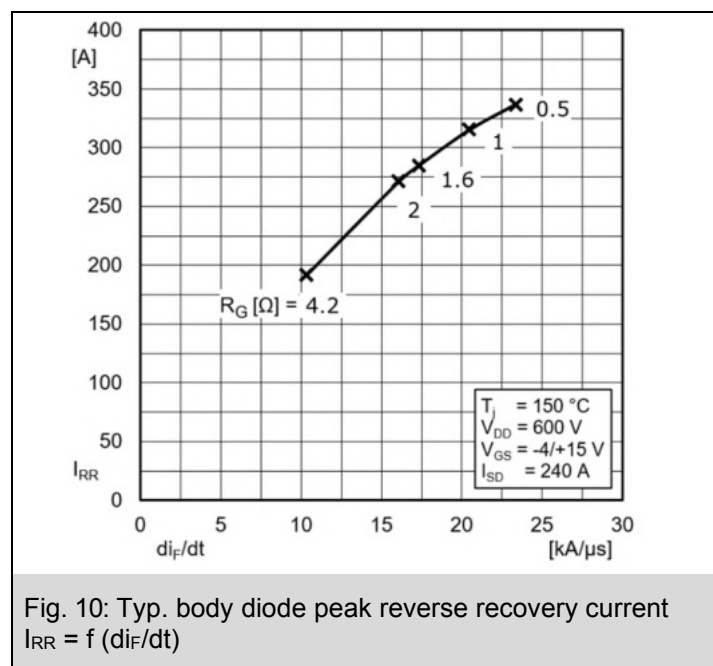
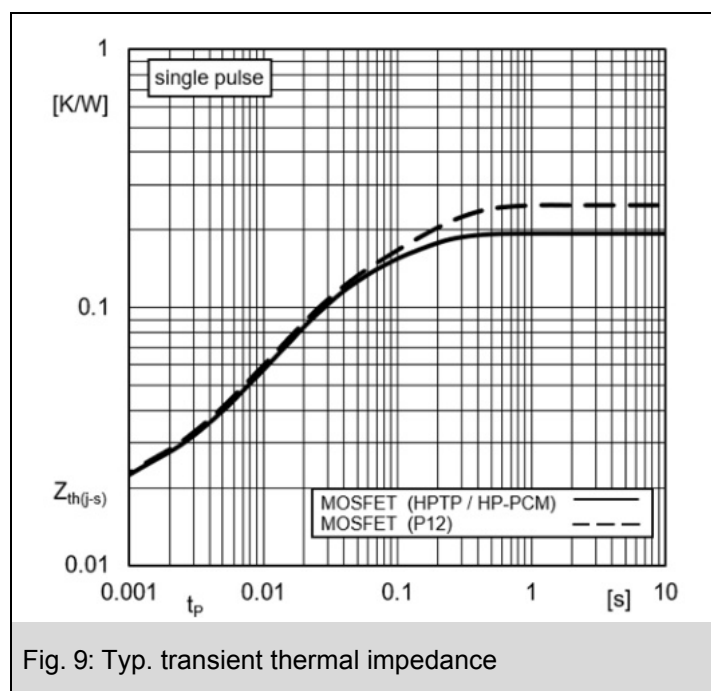
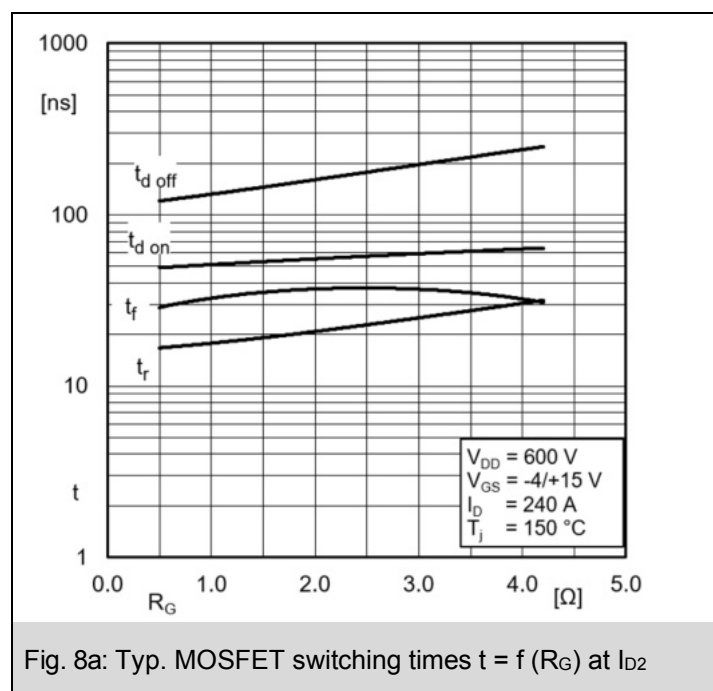
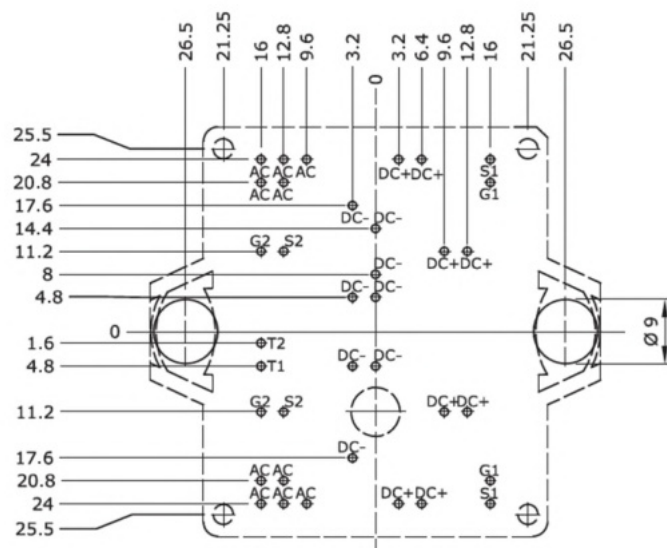
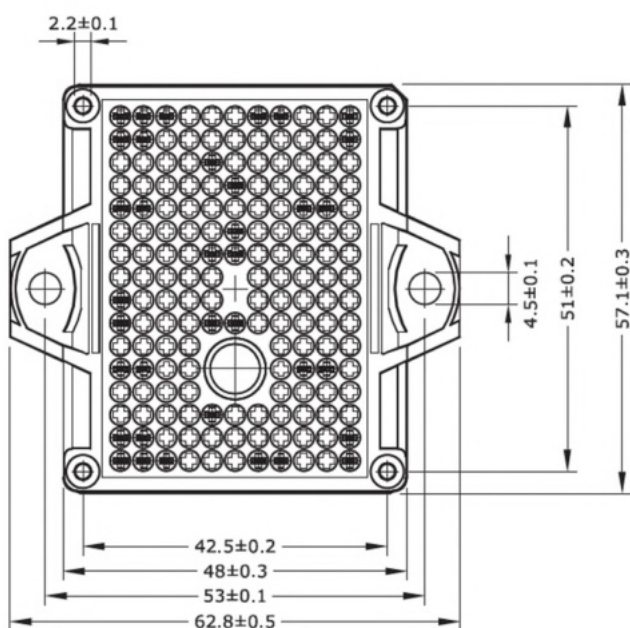
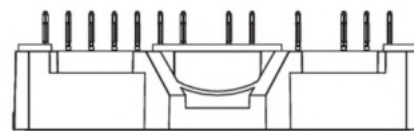
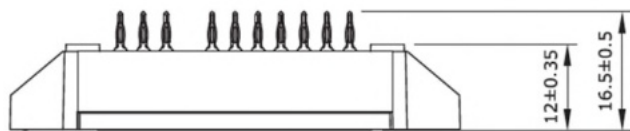


Fig. 8: Typ. MOSFET switching times  $t = f(R_G)$  at  $I_{D1}$

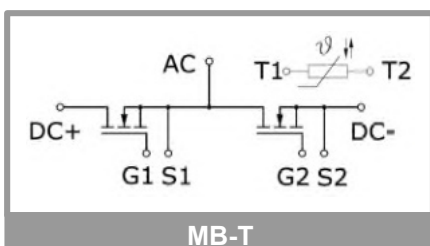






- Pin-Grid 3.2 mm
- Tolerance of PCB hole pattern  $\boxed{\oplus \varnothing 0.1}$
- Diameters of drill  $\varnothing 1.15\text{mm}$
- Copper thickness in hole 25 - 50  $\mu\text{m}$
- Hole specification for contacts:  
refer to SEMITOP E1/E2 Mounting Instruction

## Pinout and Dimensions



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

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